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| APPLICATION NO. | FILING DATE | FIRST NAMED INVENTOR | ATTORNEY DOCKET NO. | .CONFIRMATION NO. |
|-----------------------------------|---------------|-------------------------|---------------------|-------------------|
| 10/050,453 | 01/16/2002 | Bharath Rangarajan | F0595 | 6507 |
| 75 | 90 04/17/2003 | | | |
| Himanshu S. Amin | | | EXAMINER | |
| Amin & Turocy National City C | | | STAFIRA, MICHAEL | |
| 1900 E. 9th Stre Cleveland, OH | - | | ART UNIT | PAPER NUMBER |
| | | · | 2877 | |
| | | DATE MAILED: 04/17/2003 | | |

Please find below and/or attached an Office communication concerning this application or proceeding.

| | Application No. | Applicant(s) | | | | |
|---|---|--|--|--|--|--|
| | | | | | | |
| Office Action Summary | 10/050,453 Examiner | RANGARAJAN ET AL. | | | | |
| | Michael P. Stafira | Art Unit | | | | |
| The MAILING DATE of this communication app | | | | | | |
| Period for Reply / | | | | | | |
| A SHORTENED STATUTORY PERIOD FOR REPLY THE MAILING DATE OF THIS COMMUNICATION. - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a reply - If NO period for reply is specified above, the maximum statutory period w - Failure to reply within the set or extended period for reply will, by statute, - Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b). Status | 66(a). In no event, however, may a n within the statutory minimum of thir ill apply and will expire SIX (6) MON cause the application to become AE | reply be timely filed ty (30) days will be considered timely. ITHS from the mailing date of this communication. BANDONED (35 U.S.C. § 133). | | | | |
| 1) Responsive to communication(s) filed on | | | | | | |
| · | s action is non-final. | | | | | |
| Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213. | | | | | | |
| Disposition of Claims | ex parto quayro, 1000 o. | D. 11, 400 C.C. 210. | | | | |
| 4)⊠ Claim(s) <u>1-11</u> is/are pending in the application | | | | | | |
| 4a) Of the above claim(s) is/are withdrawn from consideration. | | | | | | |
| Claim(s) is/are allowed. | | | | | | |
| 6)⊠ Claim(s) <u>1-11</u> is/are rejected. | | | | | | |
| 7) Claim(s) is/are objected to. | 7) Claim(s) is/are objected to. | | | | | |
| 8) Claim(s) are subject to restriction and/or Application Papers | election requirement. | | | | | |
| 9)☐ The specification is objected to by the Examiner | . | | | | | |
| 10) The drawing(s) filed on is/are: a) accepted or b) objected to by the Examiner. | | | | | | |
| Applicant may not request that any objection to the | | | | | | |
| 11) ☐ The proposed drawing correction filed on is: a) ☐ approved b) ☐ disapproved by the Examiner. | | | | | | |
| If approved, corrected drawings are required in reply to this Office action. | | | | | | |
| 12) The oath or declaration is objected to by the Examiner. | | | | | | |
| Priority under 35 U.S.C. §§ 119 and 120 | of all condenses to a | 0.440(a) (d) an (0 | | | | |
| 13) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). | | | | | | |
| a) All b) Some * c) None of: | | | | | | |
| | 1. Certified copies of the priority documents have been received. | | | | | |
| 2. Certified copies of the priority documents have been received in Application No 3. Copies of the certified copies of the priority documents have been received in this National Stage | | | | | | |
| application from the International Bur * See the attached detailed Office action for a list | reau (PCT Rule 17.2(a)). | | | | | |
| 14) Acknowledgment is made of a claim for domestic | priority under 35 U.S.C. | § 119(e) (to a provisional application). | | | | |
| a) ☐ The translation of the foreign language prof 15)☐ Acknowledgment is made of a claim for domestic | | | | | | |
| Attachment(s) | | | | | | |
| (1) ☑ Notice of References Cited (PTO-892) 4) ☐ Interview Summary (PTO-413) Paper No(s) (2) ☐ Notice of Draftsperson's Patent Drawing Review (PTO-948) 5) ☐ Notice of Informal Patent Application (PTO-152) (3) ☑ Information Disclosure Statement(s) (PTO-1449) Paper No(s) ②. 6) ☐ Other: | | | | | | |
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DETAILED ACTION

Claim Rejections - 35 USC § 102

1. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(e) the invention was described in (1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent or (2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effects for purposes of this subsection of an application filed in the United States only if the international application designated the United States and was published under Article 21(2) of such treaty in the English language.

2. Claims 1,2,6,7 are rejected under 35 U.S.C. 102(e) as being anticipated by Subramanian et al. ('753).

The applied reference has a common assignee with the instant application. Based upon the earlier effective U.S. filing date of the reference, it constitutes prior art under 35 U.S.C. 102(e). This rejection under 35 U.S.C. 102(e) might be overcome either by a showing under 37 CFR 1.132 that any invention disclosed but not claimed in the reference was derived from the inventor of this application and is thus not the invention "by another," or by an appropriate showing under 37 CFR 1.131.

Claim 1

Subramanian et al. ('753) discloses a light source (Fig. 1, Ref. 150) directed to at least one portion of an ILD layer (Fig. 1, Ref. 130) and a measuring system (Fig. 1, Ref. 110) for measuring parameters of the ILD layer based on light reflected from the at least one portion of the ILD layer (Col. 5-6, lines 66-44). The reference of Subramanian et al. ('753) further discloses a processor operatively coupled to the measuring system, the processor receiving ILD layer parameter data from the measuring system and the processor using the data to determine the

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presence of a void in the ILD layer (See Abstract). It is the position of the examiner that the interconnecting holes are equivalent to the voids claimed in the limitations.

Claim 2

The reference of Subramanian et al. ('753) further discloses a scatterometry system for processing the light reflected from the ILD layer (Col. 6, lines 40-45).

Claim 6

Subramanian et al. ('753) further discloses the processor mapping the ILD layer into a plurality of grid blocks, detecting the presence of an ILD void at a grid block, and comparing it to known ILD void values to determined the dimensions of the void (Col. 15-16, lines 40-23).

Claim 7

The reference of Subramanian et al. ('753) further discloses that the processor determines the existence of an unacceptable ILD void for at least a portion of the ILD layer based upon the determined ILD void differing from an acceptable value (Col. 15-16, lines 40-23).

Claim Rejections - 35 USC § 103

- 1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 2. Claims 3-5 are rejected under 35 U.S.C. 103(a) as being unpatentable over Subramanian et al. ('753) as applied to claim 3 above, and further in view of Kleinknecht et al. ('213).

Claim 3

Subramanian et al. ('753) substantially teaches the claimed invention except that it does not show the measuring system further measures parameters of the ILD layer based on light passing through the ILD layer. Kleinknecht et al. ('213) shows that it is known to provide a measuring system that measures the parameters of an ILD layer based on light passing through the ILD layer (See Fig. 7) for an optical measuring system. It would have been obvious to



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combine the device of Subramanian et al. ('753) with the measuring system of passing light through the ILD layer of Kleinknecht et al. ('213) for the purpose of providing rapid and accurate determination of the widths of fine-line structures.

Claim 4

Subramanian et al. ('753) further discloses the processor being operatively coupled to the scatterometry system, the processor analyzing data relating to ILD voids received from the scatterometry system, and the processor basing a determination of whether an ILD void exists at least partially on the analyzed data (See Abstract).

Claim 5

The reference of Subramanian et al. ('753) further discloses the data further relating to thickness of the ILD layer (Col. 7, lines 32-37).

3. Claims 8-11 are rejected under 35 U.S.C. 102(e) as being anticipated by Subramanian et al. ('753).

Claim 8

Subramanian et al. ('753) discloses the steps of defining an ILD layer as a plurality of portion, directing light onto at least one of the portions; collecting light reflected from the at least one portion, comparing a reflected light array from the at least one portion to a database, where the database comprises known ILD layers having at least one void present, to determine the presence of the at least one void in the at least one portion associated with the ILD layer, and selectively marking an ILD layer portion as having the at least one void (Col. 15-16, lines 40-23).

Claim 9

The reference of Subramanian et al. ('753) further discloses using a scatterometry system to process the reflected light (Col. 6, lines 40-45).

Claim 10

Subramanian et al. ('753) discloses the step of partitioning an ILD layer into a plurality of grid blocks, directing light onto at least one grid blocks, collecting light reflected from the at least one grid block, comparing a reflected light array from the at least one grid block to a database, where the database comprises known ILD layers having at least one void present, to

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determine the presence of the at least one void in the at least one portion associated with the ILD layer, and selectively marking the LD layer grid block as having the at least one void, where the

ILD layer grid block corresponds to a portion of the ILD layer (Col. 15-16, lines 40-23).

Claim 11

Subramanian et al. ('753) discloses a means for detecting ILD void formation in a plurality of portions of the ILD layer and means for selectively marking an ILD layer portion as having a void formed therein (Col. 15-16, lines 40-23).

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Michael P. Stafira whose telephone number is 703-308-4837. The examiner can normally be reached on 4/10.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Frank Font can be reached on 703-308-4881. The fax phone numbers for the organization where this application or proceeding is assigned are 703-308-7722 for regular communications and 703-308-7721 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is 703-308-0956.

> **Primary Examiner** Art Unit 2877

April 11, 2003